

MULTI LAYER CERAMIC CAPACITORS

- GML SERIES -

DESCRIPTION

- MLCC consists of a conducting material and electrodes. To manufacture a chip-type SMT and achieve miniaturization, high density and high efficiency, ceramic condensers are used.
- CCE GML series MLCC is used in product having thickness concerned generally have high capacitance and thinner product thickness. The high dielectric constant material X7R and X5R are used for this series product.

FEATURES

- Standard size with thin thickness.
- Small size with high capacitance.
- Capacitor with lead-free termination (pure Tin).

APPLICATIONS

- For LCD panels.
- For PCMCA cards.
- For IC packaging and modules.
- Any thickness concerned products.

ORDERING INFORMATION

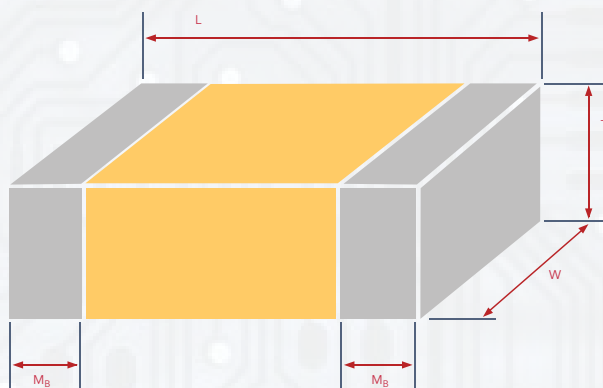
GML	21	X5R	475	K	6R3	N	T
SERIES	SIZE	DIELECTRIC	CAPACITANCE	TOLERANCE	VOLTAGE	TERMINATION	PACKAGING
GML - Low Profile	04 - 0402 (1005) 10 - 0603 (1608) 21 - 0805 (2012) 31 - 1206 (3216) 32 - 1210 (3225)	X7R X5R	Two significant digits followed by no. of zeros. And R is in place of decimal point. eg.: 475 =47x105 =4,700,000 pF =4.7μF	K: ±10% M: ±20%	Two significant digits followed by no. of zeros. And R is in place of decimal point. 6R3: 6.3 VDC 10: 10 VDC 16: 16 VDC 25: 25 VDC 50: 50 VDC 100: 100 VDC	N: Cu / Ni / Sn	T: 7" reeled G: 13" reeled

GENERAL ELECTRICAL DATA

DIELECTRIC	X7R	X5R
SIZE	0402, 0603, 0805, 1206, 1210	
CAPACITANCE RANGE*	1μF to 10μF	0.22μF to 47μF
CAPACITANCE TOLERANCE**	K (±10%), M (±20%)	
RATED VOLTAGE	10V, 16V, 25V, 50V, 100V	6.3V, 10V, 16V, 25V
OPERATING TEMPERATURE	-55 to +125°C	-55 to +85°C
CAPACITANCE CHARACTERISTIC	±15%	
TERMINATION	Ni / Sn (lead-free termination)	

* Measured at 1.0±0.2Vrms, 1.0kHz±10%, 30~70% related humidity, 25°C ambient temperature for X7R, X5R.
** Preconditioning for Class II MLCC: Perform a heat treatment at 150±10°C for 1 hour, then leave in ambient condition for 24±2 hours before measurement

DESCRIPTION



SIZE INCH (MM)	L (MM)	W (MM)	T (MM) SYMBOL	Mb (MM)
0402 (1005)	1.00 ± 0.2	0.5 ± 0.2	0.30 ± 0.03 L	0.25 ± 0.10
0603 (1608)	1.6 ± .15 / -.10	0.8 ± 0.15 / -.10	0.50 ± 0.10 H	0.40 ± 0.15
0805 (2012)	2.00 ± 0.20	1.25 ± 0.20	0.85 ± 0.10 T	0.50 ± 0.20
1206 (3216)	3.20 ± 0.20	1.60 ± 0.20	0.85 ± 0.10 T	0.60 ± 0.20
			1.15 ± 0.15 J	
1210 (3225)	3.20 ± 0.30	2.50 ± 0.20	0.85 ± 0.10 T	0.75 ± 0.25
			2.00 ± 0.20 K	

■ CAPACITANCE RANGE

- X7R DIELECTRIC

DIELECTRIC		X7R										
SIZE		0805				1206				1210		
RATED VOLTAGE		10	16	25	50	10	16	25	50	10	16	100
CAPACITANCE RANGE	1.0uF	105						T				
	1.5uF	155										
	2.2uF	225		T	T				T			K
	3.3uF	335										
	4.7uF	475	T					T				
	6.8uF	685										
	10uF	106					T					
	22uF	226										

- X5R DIELECTRIC

DIELECTRIC		X5R																				
SIZE		0402			0603			0805				1206					1210					
RATED VOLTAGE		6.3	10	25	6.3	10	16	6.3	10	16	25	6.3	10	16	25	50	10	16	25			
CAPACITANCE RANGE	0.22uF	224		L		H	H															
	0.47uF	474	F	L																		
	1.0uF	105	L			H	H		T	T	T		T	T	T	T						
	1.5uF	155							T	T			T	T	T							
	2.2uF	225	L					T	T	T	T		T	T	T	T						
	3.3uF	335											T	T	T				T			
	4.7uF	475	L			H		T	T	T	T		T	T	T				T			
	6.8uF	685																				
	10uF	106				G			T	T	T		J	J/T		T			T		T	
	22uF	226							T	T			T		T						T	
	47uF	476							T				T									

■ PACKAGING STYLE AND REEL SIZE

SIZE	THICKNESS MASS (MM) / SYMBOL		7" REEL	
			PAPER TAPE	PLASTIC TAPE
0402 (1005)	0.22	F	10k	
0402 (1005)	0.33	L	15k	-
0603 (1608)	0.50	g	4k	
0603 (1608)	0.60	H	4k	-
0805 (2012)	0.95	T	4k	-
1206 (3216)	0.95	T	4k	-
	1.30	J	-	3k
1210 (3225)	0.95	T	-	3k
	2.00	K	-	1k



RELIABILITY TEST CONDITIONS AND REQUIREMENTS

NO.	ITEMS	TEST CONDITION	REQUIREMENTS																														
1.	Visual and Mechanical	---	- No remarkable defect. - Dimensions to conform to individual specification sheet.																														
2.	Capacitance	- Test temp.: Room Temperature. Cap \leq 10 μ F, 1.0 \pm 0.2Vrms, 1KHz \pm 10% Cap $>$ 10 μ F, 0.5 \pm 0.2Vrms, 120Hz \pm 20%**	- Shall not exceed the limits given in the detailed spec.																														
3.	Q/ D.F. (Dissipation Factor)	** Test condition: 0.5 \pm 0.2Vrms, 1KHz \pm 10% GML10 X5R \geq 475(10V) , GML04 X5R series *Before initial measurement (Class II only): To apply de-aging at 150°C for 1hr then set for 24 \pm 2 hrs at room temp.	X7R / X5R: <table border="1" style="margin-left: 20px;"> <thead> <tr> <th>RATED VOL.</th> <th>D.F.</th> </tr> </thead> <tbody> <tr> <td>100V</td> <td>\leq5%</td> </tr> <tr> <td>50V, 25V, 16V, 10V</td> <td>\leq10%</td> </tr> <tr> <td>6.3V</td> <td>\leq5%</td> </tr> </tbody> </table>	RATED VOL.	D.F.	100V	\leq 5%	50V, 25V, 16V, 10V	\leq 10%	6.3V	\leq 5%																						
RATED VOL.	D.F.																																
100V	\leq 5%																																
50V, 25V, 16V, 10V	\leq 10%																																
6.3V	\leq 5%																																
4.	Dielectric Strength	- To apply voltage: 250% rated voltage. - Duration: 1 to 5 sec. - Charge and discharge current less than 50mA.	- No evidence of damage or flash over during test.																														
5.	Insulation Resistance	- Test temp.: Room Temperature. - To apply rated voltage for max. 120 sec.	\geq 10G Ω or Rx $C \geq$ 100 Ω - F whichever is smaller.																														
6.	Temperature Coefficient	With no electrical load. <table border="1" style="margin-left: 20px;"> <thead> <tr> <th>T.C.</th> <th>OPERATING TEMPERATURE</th> </tr> </thead> <tbody> <tr> <td>X7R</td> <td>-55~-125°C at 25°C</td> </tr> <tr> <td>X5R</td> <td>-55~-85°C at 25°C</td> </tr> </tbody> </table> - Before initial measurement (Class II only): To apply de-aging at 150°C for 1hr then set for 24 \pm 2 hrs at room temp. - Measurement voltage for Class II: <table border="1" style="margin-left: 20px;"> <thead> <tr> <th>0402</th> <th>0603</th> </tr> </thead> <tbody> <tr> <td>Cap$<$1μF: 1V</td> <td>Cap$<$1μF: 1V</td> </tr> <tr> <td>Cap=1μF: 0.5V** 0402 X7R 224-16V: 0.5V 0402 X7R 474-10V: 0.5V 0402 X5R 475M6R3: 0.5V</td> <td>1μFsCaps4.7μF: 0.5V 0603 X5R 106-10V: 0.5V</td> </tr> <tr> <td>1μF$<$Cap$<$10μF: 0.2V **0402 X7R 105M6R3V: 0.2V</td> <td>Cap$>$4.7μF: 0.2V</td> </tr> <tr> <td>Cap\geq10μF: 0.1V</td> <td></td> </tr> </tbody> </table> <table border="1" style="margin-left: 20px;"> <thead> <tr> <th>0805</th> <th>1206 / 1210</th> </tr> </thead> <tbody> <tr> <td>Cap$<$10μF: 1V</td> <td>Cap$<$10μF: 1V</td> </tr> <tr> <td>Cap=10μF: 0.5V 0805 X7R 475/6.3V~25V: 0.5V</td> <td>10μF$<$Caps\leq100μF: 0.5V</td> </tr> <tr> <td>Cap$>$10μF: 0.2V</td> <td>Cap$>$100μF: 0.2V 1206 X5R 107-6.3V: 0.2V</td> </tr> </tbody> </table>	T.C.	OPERATING TEMPERATURE	X7R	-55~-125°C at 25°C	X5R	-55~-85°C at 25°C	0402	0603	Cap $<$ 1 μ F: 1V	Cap $<$ 1 μ F: 1V	Cap=1 μ F: 0.5V** 0402 X7R 224-16V: 0.5V 0402 X7R 474-10V: 0.5V 0402 X5R 475M6R3: 0.5V	1 μ FsCaps4.7 μ F: 0.5V 0603 X5R 106-10V: 0.5V	1 μ F $<$ Cap $<$ 10 μ F: 0.2V **0402 X7R 105M6R3V: 0.2V	Cap $>$ 4.7 μ F: 0.2V	Cap \geq 10 μ F: 0.1V		0805	1206 / 1210	Cap $<$ 10 μ F: 1V	Cap $<$ 10 μ F: 1V	Cap=10 μ F: 0.5V 0805 X7R 475/6.3V~25V: 0.5V	10 μ F $<$ Caps \leq 100 μ F: 0.5V	Cap $>$ 10 μ F: 0.2V	Cap $>$ 100 μ F: 0.2V 1206 X5R 107-6.3V: 0.2V	<table border="1" style="margin-left: 20px;"> <thead> <tr> <th>T.C.</th> <th>CAPACITANCE CHANGE</th> </tr> </thead> <tbody> <tr> <td>X7R</td> <td>Within \pm15%</td> </tr> <tr> <td>X5R</td> <td>Within \pm15%</td> </tr> </tbody> </table>	T.C.	CAPACITANCE CHANGE	X7R	Within \pm 15%	X5R	Within \pm 15%
T.C.	OPERATING TEMPERATURE																																
X7R	-55~-125°C at 25°C																																
X5R	-55~-85°C at 25°C																																
0402	0603																																
Cap $<$ 1 μ F: 1V	Cap $<$ 1 μ F: 1V																																
Cap=1 μ F: 0.5V** 0402 X7R 224-16V: 0.5V 0402 X7R 474-10V: 0.5V 0402 X5R 475M6R3: 0.5V	1 μ FsCaps4.7 μ F: 0.5V 0603 X5R 106-10V: 0.5V																																
1 μ F $<$ Cap $<$ 10 μ F: 0.2V **0402 X7R 105M6R3V: 0.2V	Cap $>$ 4.7 μ F: 0.2V																																
Cap \geq 10 μ F: 0.1V																																	
0805	1206 / 1210																																
Cap $<$ 10 μ F: 1V	Cap $<$ 10 μ F: 1V																																
Cap=10 μ F: 0.5V 0805 X7R 475/6.3V~25V: 0.5V	10 μ F $<$ Caps \leq 100 μ F: 0.5V																																
Cap $>$ 10 μ F: 0.2V	Cap $>$ 100 μ F: 0.2V 1206 X5R 107-6.3V: 0.2V																																
T.C.	CAPACITANCE CHANGE																																
X7R	Within \pm 15%																																
X5R	Within \pm 15%																																
7.	Adhesive Strength of Termination	- Pressurizing force: 5N (\leq 0603) and 10N ($>$ 0603) - Test time: 10 \pm 1 sec.	- No remarkable damage or removal of the terminations.																														
8.	Vibration Resistance	- Vibration frequency: 10~55 Hz/min. - Total amplitude: 1.5mm - Test time: 6 hrs. (Two hrs each in three mutually perpendicular directions.) - Before initial measurement (Class II only): To apply de-aging at 150°C for 1hr then set for 24 \pm 2 hrs at room temp. - Cap./DF(Q) Measurement to be made after de-aging at 150°C for 1hr then set for 24 \pm 2 hrs at room temp	- No remarkable damage. - Cap change and Q/D.F.: To meet initial spec.																														
9.	Solderability	- Solder temperature: 235 \pm 5°C - Dipping time: 2 \pm 0.5 sec.	- 95% min. coverage of all metalized area.																														
10.	Bending Test	- The middle part of substrate shall be pressurized by means of the pressurizing rod at a rate of about 1 mm per second until the deflection becomes 1 mm and then the pressure shall be maintained for 5 \pm 1 sec. - Before initial measurement (Class II only): To apply de-aging at 150°C for 1hr then set for 24 \pm 2 hrs at room temp. - Measurement to be made after keeping at room temp. for 24 \pm 2 hrs.	- No remarkable damage. - Cap change: X7R/X5R: within \pm 12.5% (This capacitance change means the change of capacitance underspecified flexure of substrate from the capacitance measured before the test.)																														

RELIABILITY TEST CONDITIONS AND REQUIREMENTS

NO.	ITEMS	TEST CONDITION	REQUIREMENTS																						
11.	Resistance to Soldering Heat	<ul style="list-style-type: none"> - Solder temperature: 260±5°C - Dipping time: 10±1 sec - Preheating: 120 to 150°C for 1 minute before immerse the capacitor in a eutectic solder. - Before initial measurement (Class II only): To apply de-aging at 150°C for 1hr then set for 24±2 hrs at room temp . - Cap. / DF(Q) / I.R. Measurement to be made after de-aging at 150°C for 1hr then set for 24±2 hrs at room temp. 	<ul style="list-style-type: none"> - No remarkable damage. - Cap change: X7R/X5R: within ±7.5% - Q/D.F., I.R. and dielectric strength: To meet initial requirements. - 25% max. leaching on each edge. 																						
12.	Temperature Cycle	<ul style="list-style-type: none"> - Conduct the five cycles according to the temperatures and time. <table border="1"> <thead> <tr> <th>STEP</th> <th>TEMP. (°C)</th> <th>TIME (MIN)</th> </tr> </thead> <tbody> <tr> <td>1</td> <td>Min. operating temp. +0/-3</td> <td>30±3</td> </tr> <tr> <td>2</td> <td>Room Temp</td> <td>2-3</td> </tr> <tr> <td>3</td> <td>Max. operating temp. +3/-0</td> <td>30±3</td> </tr> <tr> <td>4</td> <td>Room Temp</td> <td>2-3</td> </tr> </tbody> </table> <ul style="list-style-type: none"> - Before initial measurement (Class II only): To apply de-aging at 150°C for 1hr then set for 24±2 hrs at room temp . - Cap. / DF(Q) / I.R. Measurement to be made after de-aging at 150°C for 1hr then set for 24±2 hrs at room temp . 	STEP	TEMP. (°C)	TIME (MIN)	1	Min. operating temp. +0/-3	30±3	2	Room Temp	2-3	3	Max. operating temp. +3/-0	30±3	4	Room Temp	2-3	<ul style="list-style-type: none"> - No remarkable damage. - Cap change: X7R/X5R: within ±7.5% - Q/D.F., I.R. and dielectric strength: To meet initial requirements. 							
STEP	TEMP. (°C)	TIME (MIN)																							
1	Min. operating temp. +0/-3	30±3																							
2	Room Temp	2-3																							
3	Max. operating temp. +3/-0	30±3																							
4	Room Temp	2-3																							
13.	Humidity (Damp Heat) Steady State	<ul style="list-style-type: none"> - Test temp.: 40±2°C - Humidity: 90~95% RH - Test time: 500+24/-0hrs. - Before initial measurement (Class II only): To apply de-aging at 150°C for 1hr then set for 24±2 hrs at room temp. - Cap. / DF(Q) / I.R. Measurement to be made after de-aging at 150°C for 1hr then set for 24±2 hrs at room temp . 	<ul style="list-style-type: none"> - No remarkable damage. - Cap change: X7R/X5R: within ±25% - Q/D.F. value: X7R/X5R: <table border="1"> <thead> <tr> <th>RATED VOL.</th> <th>D.F.</th> </tr> </thead> <tbody> <tr> <td>100V</td> <td>≤7.5%</td> </tr> <tr> <td>25V, 16V</td> <td>≤15%</td> </tr> <tr> <td>10V</td> <td>≤20%</td> </tr> <tr> <td>50V, 6.3V</td> <td>≤30%</td> </tr> </tbody> </table> <ul style="list-style-type: none"> - I.R.: 1G Ω or RxC≥10 Ω -F whichever is smaller. 	RATED VOL.	D.F.	100V	≤7.5%	25V, 16V	≤15%	10V	≤20%	50V, 6.3V	≤30%												
RATED VOL.	D.F.																								
100V	≤7.5%																								
25V, 16V	≤15%																								
10V	≤20%																								
50V, 6.3V	≤30%																								
14.	Humidity (Damp Heat) Load	<ul style="list-style-type: none"> - Test temp.: 40±2°C - Humidity: 90~95%RH - Test time: 500+24/-0 hrs. - To apply voltage: Rated voltage. - Before initial measurement (Class II only): To apply de-aging at 150°C for 1hr then set for 24±2 hrs at room temp . - Cap. / DF(Q) / I.R. Measurement to be made after de-aging at 150°C for 1hr then set for 24±2 hrs at room temp . 	<ul style="list-style-type: none"> No remarkable damage. *Cap change: X7R/X5R: within ±25% *Q/D.F. value: X7R/X5R: <table border="1"> <thead> <tr> <th>RATED VOL.</th> <th>D.F.</th> </tr> </thead> <tbody> <tr> <td>100V</td> <td>≤7.5%</td> </tr> <tr> <td>25V, 16V</td> <td>≤15%</td> </tr> <tr> <td>10V</td> <td>≤20%</td> </tr> <tr> <td>50V, 6.3V</td> <td>≤30%</td> </tr> </tbody> </table> <ul style="list-style-type: none"> - I.R.: 500MΩ or RxC≥5 Ω-F whichever is smaller. 	RATED VOL.	D.F.	100V	≤7.5%	25V, 16V	≤15%	10V	≤20%	50V, 6.3V	≤30%												
RATED VOL.	D.F.																								
100V	≤7.5%																								
25V, 16V	≤15%																								
10V	≤20%																								
50V, 6.3V	≤30%																								
15.	High Temperature Load (Endurance)	<ul style="list-style-type: none"> - Test temp.: X7R: 125±3°C X5R: 85±3°C - Test time: 1000+24/-0 hrs. - To apply voltage: 150% of rated voltage. **100% of rated voltage for below range. <table border="1"> <thead> <tr> <th>SIZE</th> <th>DIELECTRIC</th> <th>RATED VOLTAGE</th> <th>CAPACITANCE RANGE</th> </tr> </thead> <tbody> <tr> <td>GML04</td> <td>X5R</td> <td>6.3V</td> <td>C ≥ 1.0 μF</td> </tr> <tr> <td>GML21</td> <td>X5R X7R X6S</td> <td>≤10V</td> <td>C ≥ 10 μF</td> </tr> </tbody> </table> <ul style="list-style-type: none"> - Before initial measurement (Class II only): To apply de-aging at 150°C for 1hr then set for 24±2 hrs at room temp . * - Cap. / DF(Q) / I.R. Measurement to be made after de-aging at 150°C for 1hr then set for 24±2 hrs at room temp. 	SIZE	DIELECTRIC	RATED VOLTAGE	CAPACITANCE RANGE	GML04	X5R	6.3V	C ≥ 1.0 μF	GML21	X5R X7R X6S	≤10V	C ≥ 10 μF	<ul style="list-style-type: none"> - No remarkable damage. - Cap change: X7R/X5R: within ±25% - Q/D.F. value: X7R/X5R: <table border="1"> <thead> <tr> <th>RATED VOL.</th> <th>D.F.</th> </tr> </thead> <tbody> <tr> <td>100V</td> <td>≤7.5%</td> </tr> <tr> <td>25V, 16V</td> <td>≤15%</td> </tr> <tr> <td>10V</td> <td>≤20%</td> </tr> <tr> <td>50V, 6.3V</td> <td>≤30%</td> </tr> </tbody> </table> <ul style="list-style-type: none"> - I.R.: 1GΩ or RxC≥10Ω-F whichever is smaller. 	RATED VOL.	D.F.	100V	≤7.5%	25V, 16V	≤15%	10V	≤20%	50V, 6.3V	≤30%
SIZE	DIELECTRIC	RATED VOLTAGE	CAPACITANCE RANGE																						
GML04	X5R	6.3V	C ≥ 1.0 μF																						
GML21	X5R X7R X6S	≤10V	C ≥ 10 μF																						
RATED VOL.	D.F.																								
100V	≤7.5%																								
25V, 16V	≤15%																								
10V	≤20%																								
50V, 6.3V	≤30%																								

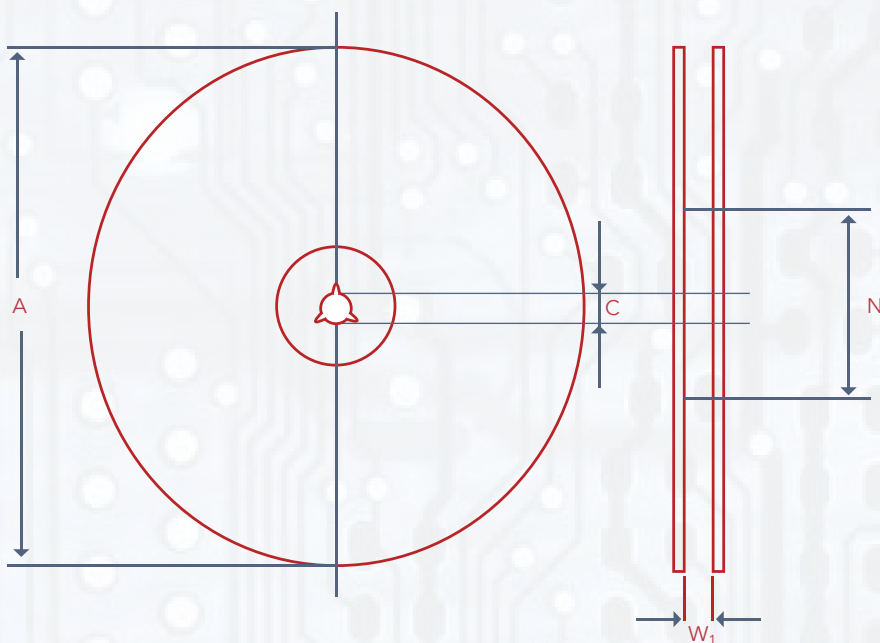
* "Room condition" Temperature: 15 to 35°C, Relative humidity: 25 to 75%, Atmospheric pressure: 86 to 106kPa.



RELIABILITY TEST CONDITIONS AND REQUIREMENTS

NO.	ITEMS	TEST CONDITION	REQUIREMENTS																						
15.	High Temperature Load (Endurance)	- Test temp.: X7R: 125±3°C X5R: 85±3°C - Test time: 1000+24/-0 hrs. - To apply voltage: 150% of rated voltage. **100% of rated voltage for below range.	- No remarkable damage. - Cap change: X7R/X5R: within ±25% - Q/D.F. value: X7R/X5R:																						
		<table border="1"> <thead> <tr> <th>SIZE</th> <th>DIELECTRIC</th> <th>RATED VOLTAGE</th> <th>CAPACITANCE RANGE</th> </tr> </thead> <tbody> <tr> <td>GML04</td> <td>X5R</td> <td>6.3V</td> <td>C ≥ 1.0 μF</td> </tr> <tr> <td>GML21</td> <td>X5R X7R</td> <td>≤10V</td> <td>C ≥ 10 μF</td> </tr> </tbody> </table>	SIZE	DIELECTRIC	RATED VOLTAGE	CAPACITANCE RANGE	GML04	X5R	6.3V	C ≥ 1.0 μF	GML21	X5R X7R	≤10V	C ≥ 10 μF	<table border="1"> <thead> <tr> <th>RATED VOL.</th> <th>D.F.</th> </tr> </thead> <tbody> <tr> <td>100V</td> <td>≤7.5%</td> </tr> <tr> <td>25V, 16V</td> <td>≤15%</td> </tr> <tr> <td>10V</td> <td>≤20%</td> </tr> <tr> <td>50V, 6.3V</td> <td>≤30%</td> </tr> </tbody> </table>	RATED VOL.	D.F.	100V	≤7.5%	25V, 16V	≤15%	10V	≤20%	50V, 6.3V	≤30%
		SIZE	DIELECTRIC	RATED VOLTAGE	CAPACITANCE RANGE																				
		GML04	X5R	6.3V	C ≥ 1.0 μF																				
GML21	X5R X7R	≤10V	C ≥ 10 μF																						
RATED VOL.	D.F.																								
100V	≤7.5%																								
25V, 16V	≤15%																								
10V	≤20%																								
50V, 6.3V	≤30%																								
- Before initial measurement (Class II only): To apply de-aging at 150°C for 1hr then set for 24±2 hrs at room temp . * - Cap. / DF(Q) / I.R. Measurement to @r de-aging at 150°C for 1hr then set for 24±2 hrs at room temp.	- I.R.: 1GΩ or RxC≥10Ω·F whichever is smaller.																								

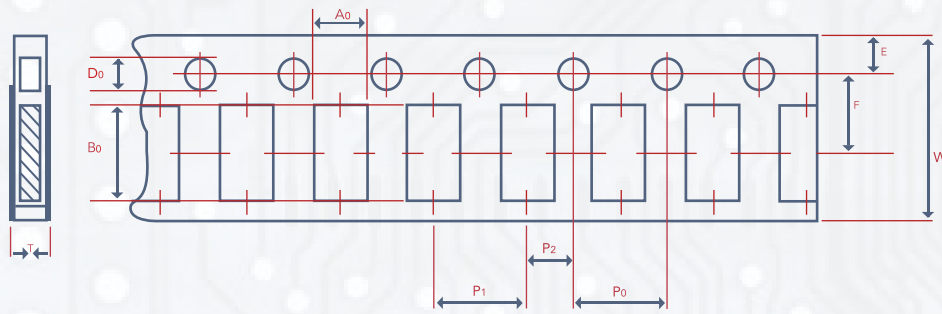
TAPE AND REEL DIMENSION



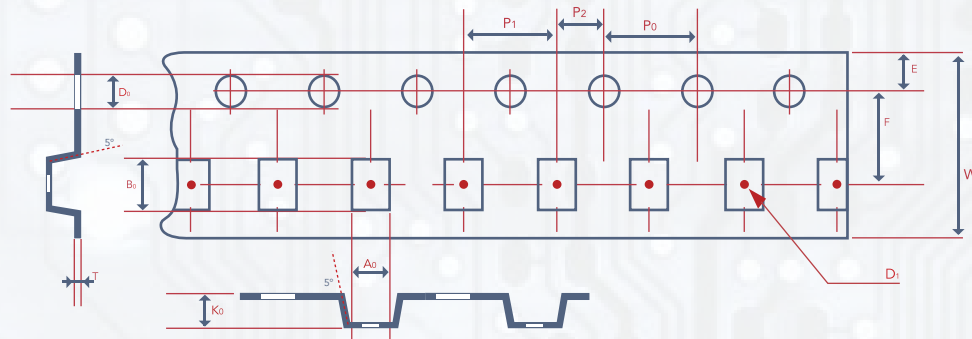
SIZE	0402, 0603, 0805, 1206, 1210		
REEL SIZE	7"	10"	13"
C	13.0±0.5	13.0±0.5	13.0±0.5
W ₁	10.0±1.5	10.0±1.5	10.0±1.5
A	178.0±2.0	250.0±2.0	330.0±2.0
N	60.0+1.0/-0	50 min	50 min

TAPE AND REEL DIMENSIONS

-The dimension of paper tape



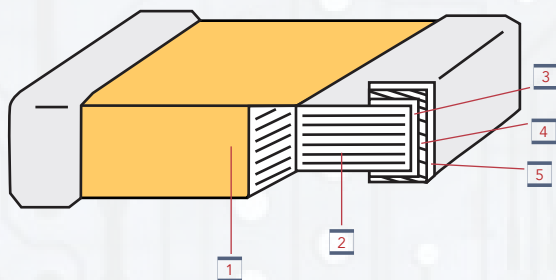
-The dimension of plastic tape



SIZE	0402	0603	0805	1206		1210	
THICKNESS	L	H	T	T	J	T	K
A ₀	0.70 ± 0.20	1.05 ± 0.30	1.50 ± 0.20	1.90 ± 0.50	<2.00	<3.05	<3.05
B ₀	1.20 ± 0.20	1.80 ± 0.30	2.30 ± 0.20	3.50 ± 0.50	<3.70	<3.80	<3.80
T	≤0.80	≤1.20	≤1.20	≤1.20	0.23 ± 0.1	0.23 ± 0.1	0.23 ± 0.1
K ₀	-	-	-	-	<2.00	<1.50	<2.50
W	8.00 ± 0.30	8.00 ± 0.30	8.00 ± 0.30	8.00 ± 0.30	8.00 ± 0.30	8.00 ± 0.30	8.00 ± 0.30
P ₀	4.00 ± 0.10	4.00 ± 0.10	4.00 ± 0.10	4.00 ± 0.10	4.00 ± 0.10	4.00 ± 0.10	4.00 ± 0.10
10XP ₀	40.00 ± 0.10	40.00 ± 0.20	40.00 ± 0.20	40.00 ± 0.20	40.00 ± 0.20	40.00 ± 0.20	40.00 ± 0.20
P ₁	2.00 ± 0.05	4.00 ± 0.10	4.00 ± 0.10	4.00 ± 0.10	4.00 ± 0.10	4.00 ± 0.10	4.00 ± 0.10
P ₂	2.00 ± 0.05	2.00 ± 0.05	2.00 ± 0.05	2.00 ± 0.05	2.00 ± 0.05	2.00 ± 0.05	2.00 ± 0.05
D ₀	1.50 +0.1 / -0	1.50 +0.1 / -0	1.50 +0.1 / -0	1.50 +0.1 / -0	1.50 +0.1 / -0	1.50 +0.1 / -0	1.50 +0.1 / -0
D ₁	-	-	-	-	1.00 ± 0.10	1.00 ± 0.10	1.00 ± 0.10
E	1.75 ± 0.10	1.75 ± 0.10	1.75 ± 0.10	1.75 ± 0.10	1.75 ± 0.10	1.75 ± 0.10	1.75 ± 0.10
F	3.50 ± 0.05	3.50 ± 0.05	3.50 ± 0.05	3.50 ± 0.05	3.50 ± 0.05	3.50 ± 0.05	3.50 ± 0.05



CONSTRUCTIONS



NO.	NAME	X7R, X5R
1	Ceramic Material	BaTiO ₃ based
2	Inner Electrode	Ni
3	Termination	Inner Layer
4		Middle Layer
5		Outer Layer
		Sn (Matt)

STORAGE AND HANDLING CONDITIONS

- (1) To store products at 5 to 40°C ambient temperature and 20 to 70% related humidity conditions.
- (2) The product is recommended to be used within one year after shipment. Check solderability in case of shelf life extension is needed.

Cautions:

- a. The corrosive gas reacts on the terminal electrodes of capacitors, and results in the poor solderability. Do not store the capacitors in the ambience of corrosive gas (e.g., hydrogen sulfide, sulfur dioxide, chlorine, ammonia gas etc.)
- b. In corrosive atmosphere, solderability might be degraded, and silver migration might occur to cause low reliability.
- c. Due to the dewing by rapid humidity change, or the photochemical change of the terminal electrode by direct sunlight, the solderability and electrical performance may deteriorate. Do not store capacitors under direct sunlight or dewing condition. To store products on the shelf and avoid exposure to moisture.

RECOMMENDED SOLDERING CONDITIONS

The lead-free termination MLCCs are not only to be used on SMT against lead-free solder paste, but also suitable against lead-containing solder paste. If the optimized solder joint is requested, increasing soldering time, temperature and concentration of N₂ within oven are recommended.

